	Application No.	Applicant(s)
Notice of Allowability	10/020,208 Examiner	BHATTACHARYA ET AL. Art Unit
	Gene N Auduong	2818
The MAILING DATE of this communication at All claims being allowable, PROSECUTION ON THE MERITS herewith (or previously mailed), a Notice of Allowance (PTOL NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATEN of the Office or upon petition by the applicant. See 37 CFR 1. 1. This communication is responsive to ree filed October	S IS (OR REMAINS) CLOSED in the second of th	this application. If not included nication will be mailed in due course. THIS
2. The allowed claim(s) is/are 1-13.		
3. A The drawings filed on 18 December 2001 are accepted	d by the Examiner.	
 4. ☐ Acknowledgment is made of a claim for foreign priorit a) ☐ All b) ☐ Some* c) ☐ None of the: 	ty under 35 U.S.C. § 119(a)-(d) or	· (f).
 Certified copies of the priority documents t 	nave been received.	
Certified copies of the priority documents t	nave been received in Application	No
Copies of the certified copies of the priority	y documents have been received	in this national stage application from the
International Bureau (PCT Rule 17.2(a)).	
* Certified copies not received:		
5. Acknowledgment is made of a claim for domestic priori reference was included in the first sentence of the spec	cification or in an Application Data	Sheet. 37 CFR 1.78.
(a) The translation of the foreign language provision	• •	
6. Acknowledgment is made of a claim for domestic priori in the first sentence of the specification or in an Application		121 since a specific reference was included
Applicant has THREE MONTHS FROM THE "MAILING DATE below. Failure to timely comply will result in ABANDONMEN"		
7. A SUBSTITUTE OATH OR DECLARATION must be sunformal PATENT APPLICATION (PTO-152) which		
 8. ☐ CORRECTED DRAWINGS (as "replacement sheets") (a) ☐ including changes required by the Notice of Drafts 1) ☐ hereto or 2) ☐ to Paper No 	person's Patent Drawing Review	
(b) ☐ including changes required by the proposed drawi	ng correction filed, which	has been approved by the Examiner.
(c) 🔲 including changes required by the attached Exami	ner's Amendment / Comment or i	n the Office action of Paper No
Identifying indicia such as the application number (see 37 Cleach sheet. Replacement sheet(s) should be labeled as such	FR 1.84(c)) should be written on the in the margin according to 37 CFR	e drawings in the front (not the back) of R 1.121(d).
9. DEPOSIT OF and/or INFORMATION about the d attached Examiner's comment regarding REQUIREMENT FO	eposit of BIOLOGICAL MATE OR THE DEPOSIT OF BIOLOGIC	RIAL must be submitted. Note the AL MATERIAL.
Attachment(s)		
1⊠ Notice of References Cited (PTO-892)	-	mal Patent Application (PTO-152)
2☐ Notice of Draftperson's Patent Drawing Review (PTO-94 3☐ Information Disclosure Statements (PTO-1449 or PTO/S	D/Ne)	nmary (PTO-413), Paper No mendment/Comment
Paper No 4 Examiner's Comment Regarding Requirement for Depos	it 8 Examiner's St	atement of Reasons for Allowance
of Biological Material	9☐ Other .	(i)
		Gene N Auduong

Continued Examination Under 37 CFR 1.114

A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on July 23, 2001 has been entered.

Information Disclosure Statement

This office acknowledges receipt of the following items from the applicant:

The Pre-amendment filed on July 23, 2001 have been entered and made of record

Allowable Subject Matter

Claims 1-13 are allowed.

The following is an examiner's statement of reasons for allowance: The prior art does not teach or fairly disclose a semiconductor wafer having one or more die with a static random access memory array integrated therein comprising a test circuit integrated with the sram array; wherein during probing, the test circuit applies a voltage difference across a plurality of adjacent bitline pairs and/or wordline pairs of the sram array, the difference being larger than an operational supply voltage for the sram array, to identify whether electrical shorting occurs across one or more of the plurality of adjacent bitline pairs and/or wordline pairs.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Gene N Auduong whose telephone number is (703) 305-1343 and the new phone number after January 8, 2003 will be (571) 272-1773.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David Nelms can be reached on (703) 308-4910 and the new phone number after January 8, 2004 will be (571) 272-1787. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9318.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

GA December 11, 2003

Gene N Auduong Primary Examiner Art Unit 2818